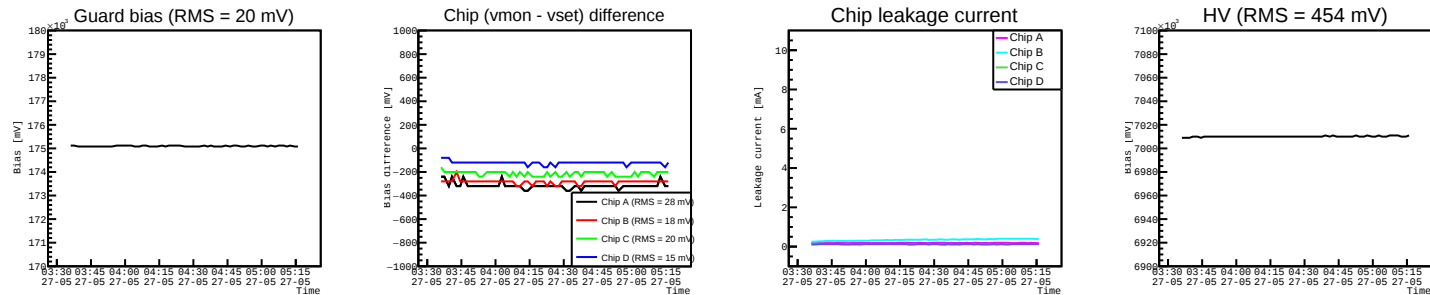


End of measuring: Fri May 27 07:12:19 2016

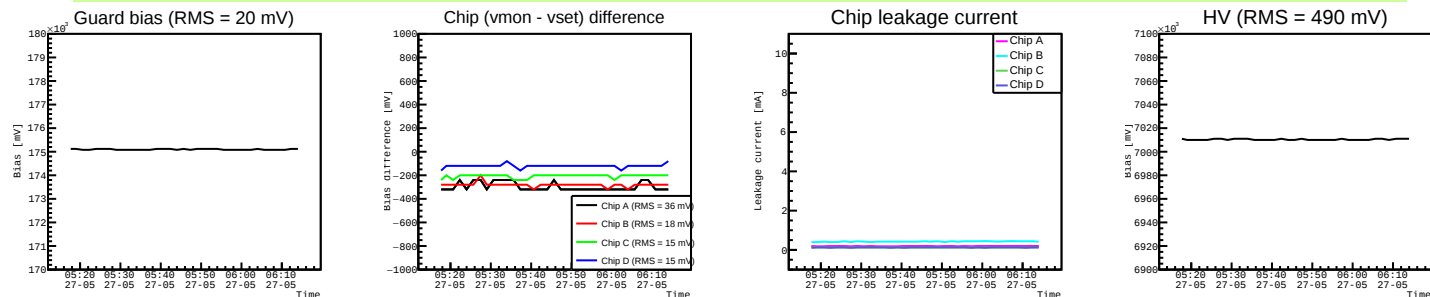
Threshold and Waveform

Fri May 27 03:36:06 2016



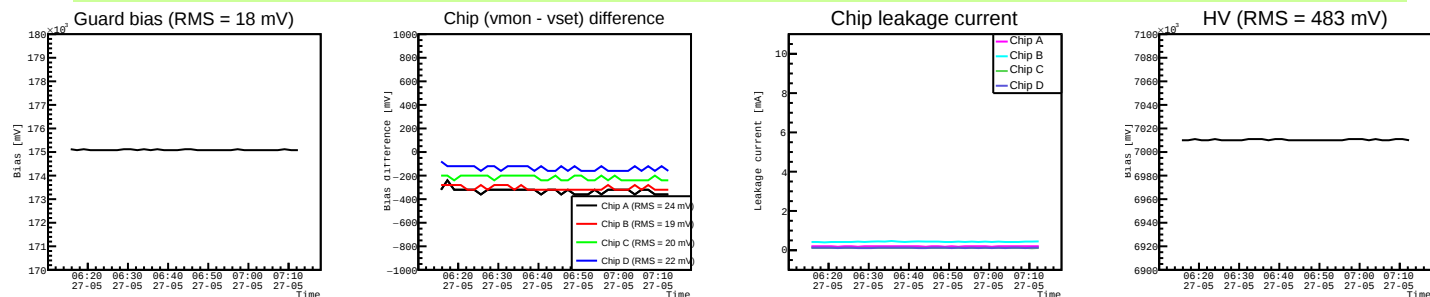
2D in X

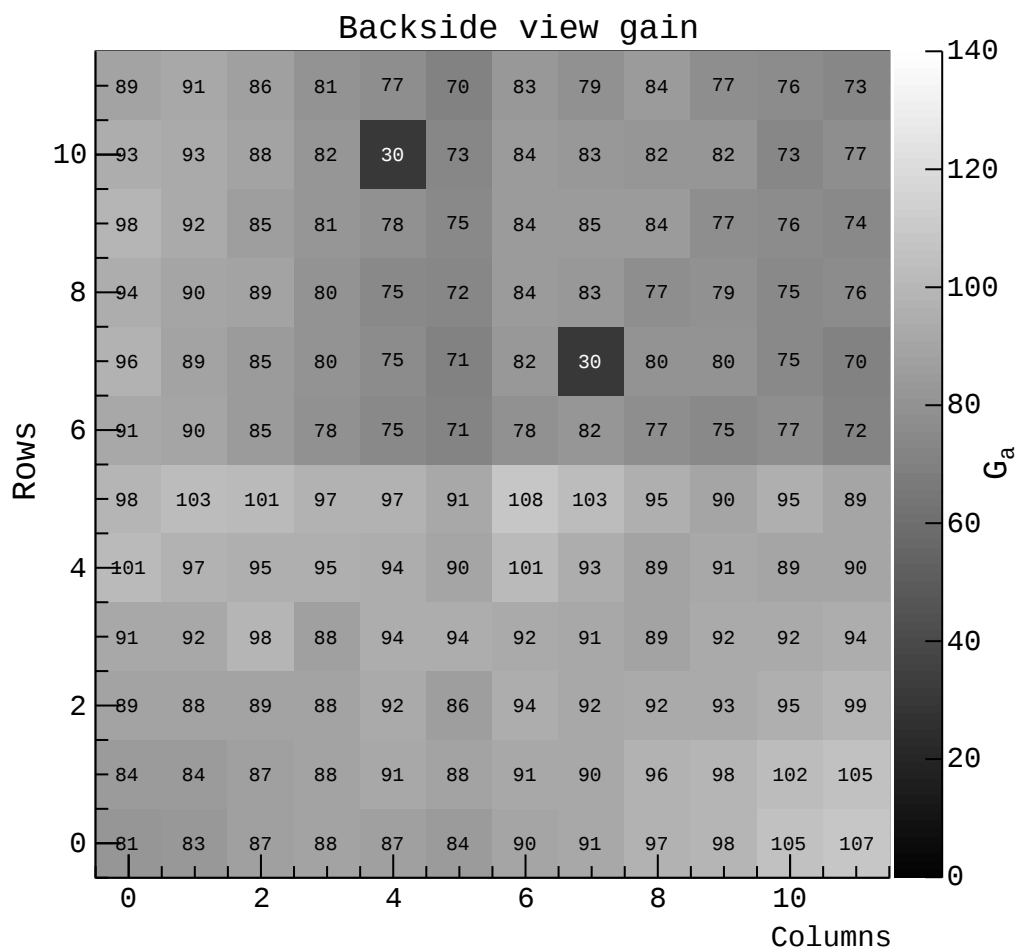
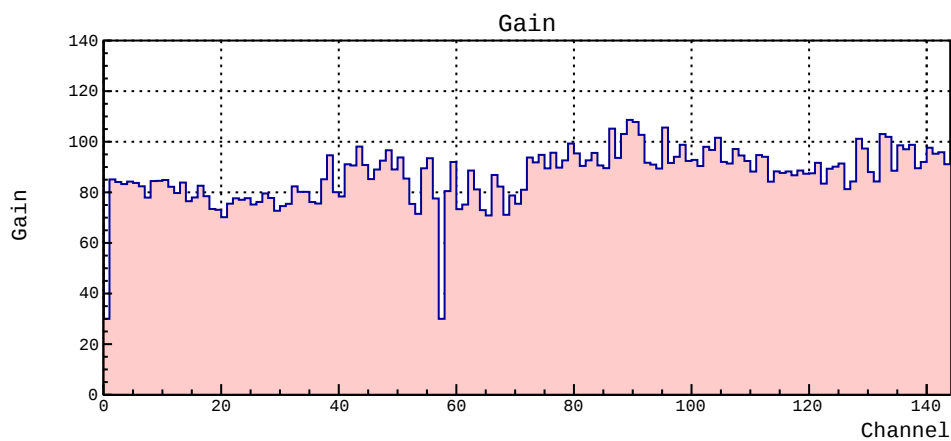
Fri May 27 05:17:41 2016



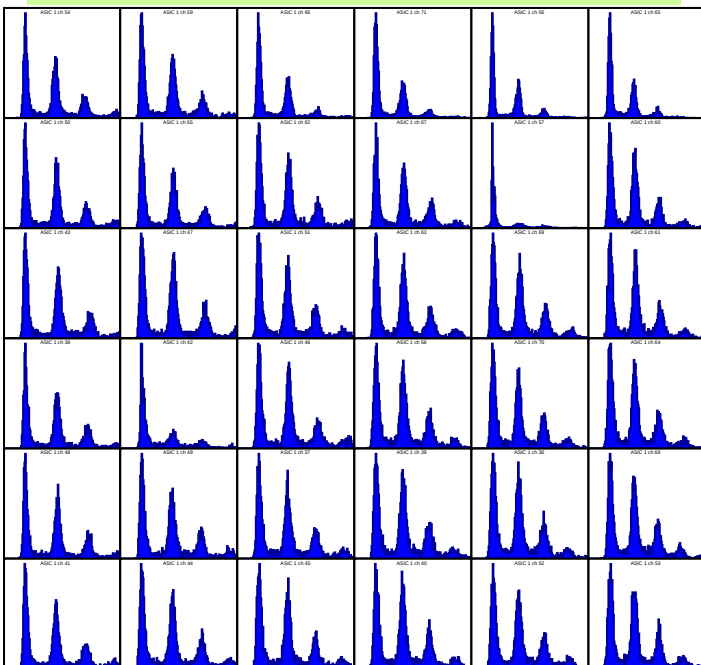
2D in Y

Fri May 27 06:15:45 2016

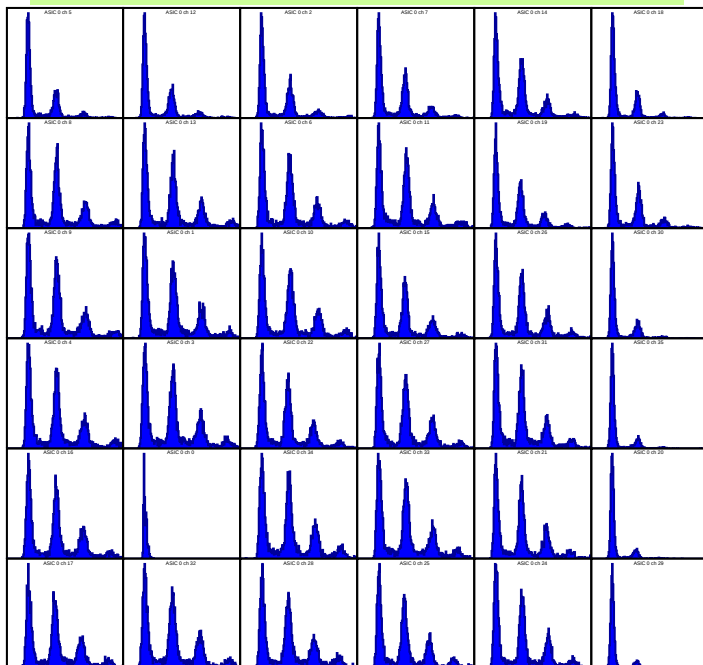




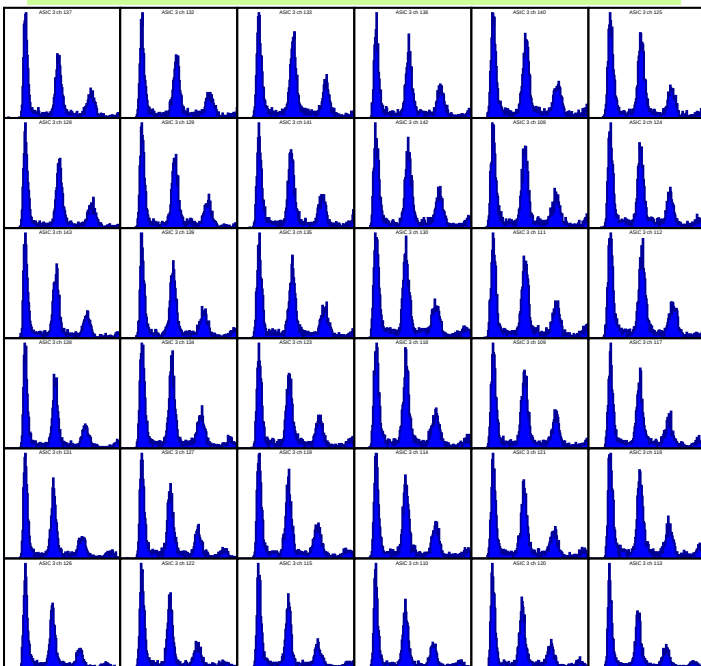
Charge scan over center of channels: Chip B



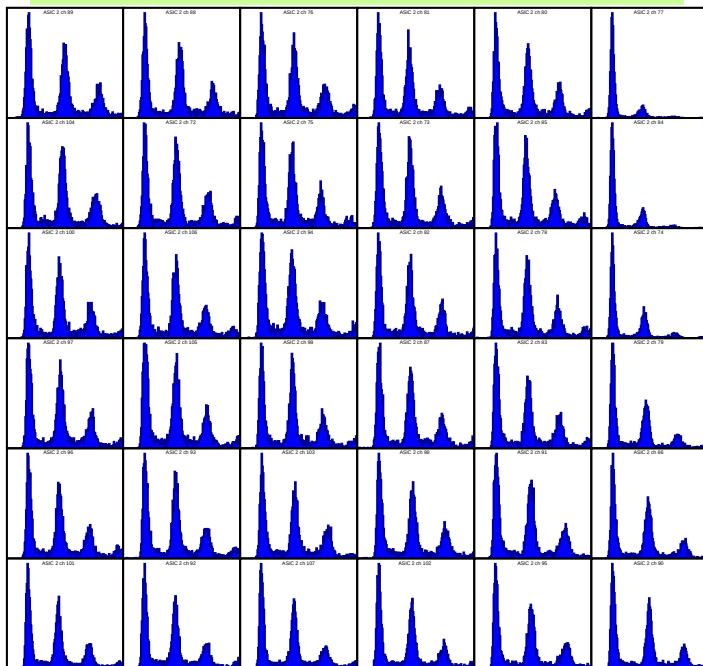
Charge scan over center of channels: Chip A



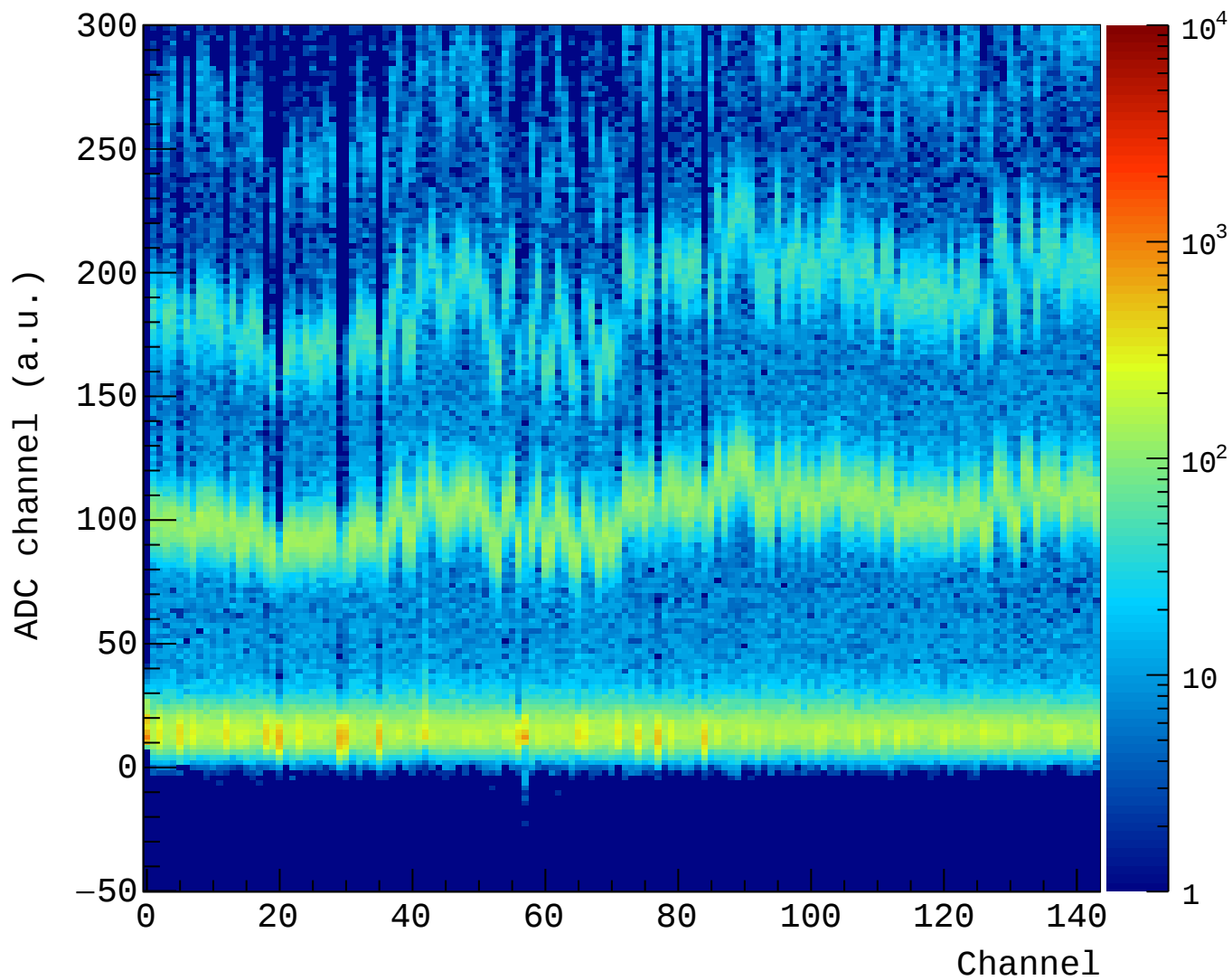
Charge scan over center of channels: Chip C



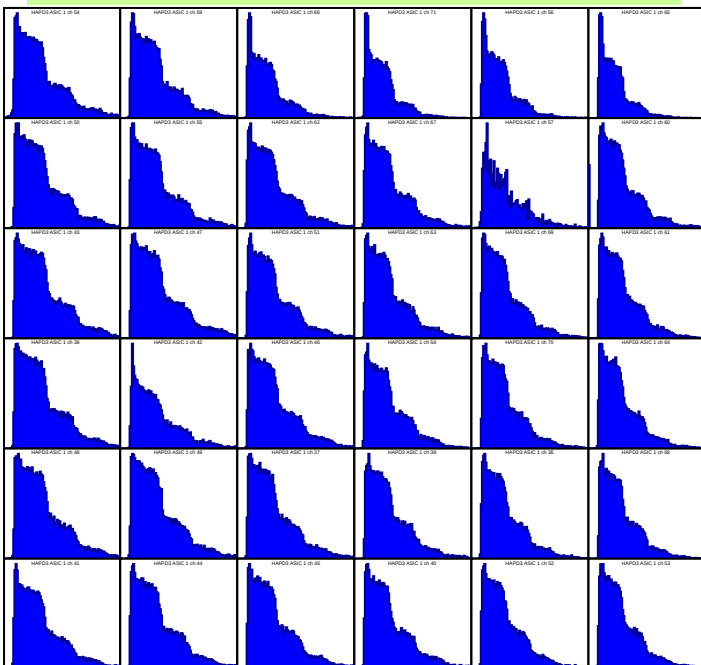
Charge scan over center of channels: Chip D



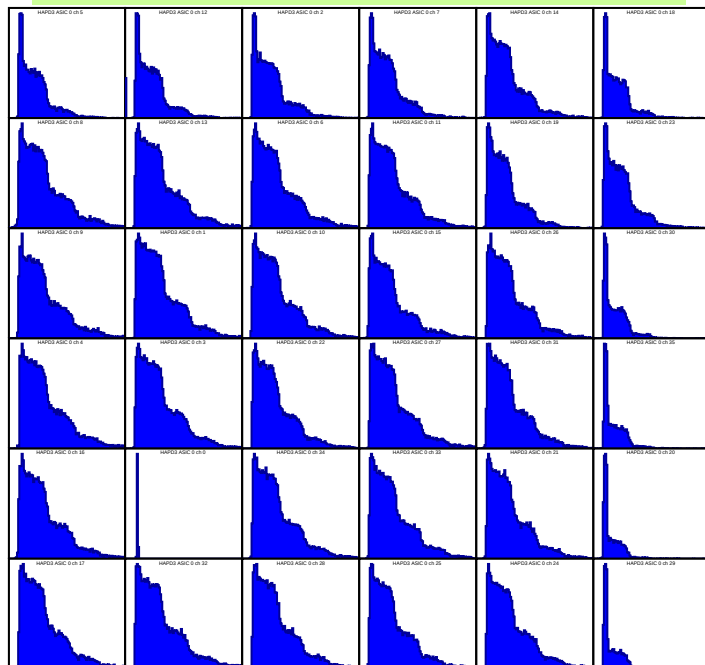
Charge scan over the center of channels



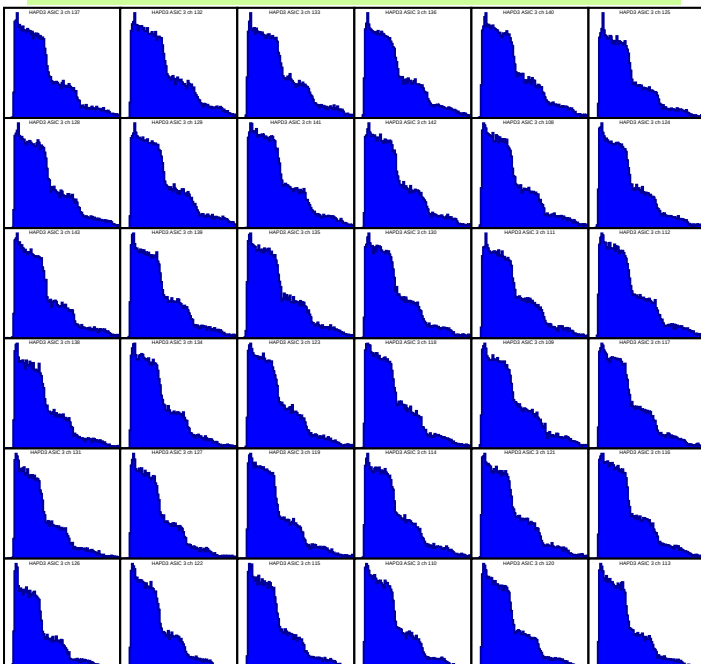
Threshold scan over center of channels: Chip B



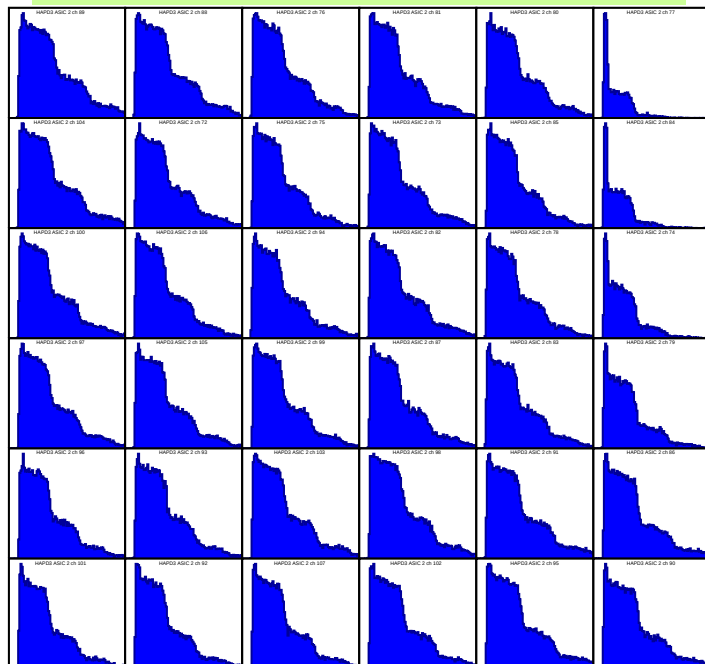
Threshold scan over center of channels: Chip A



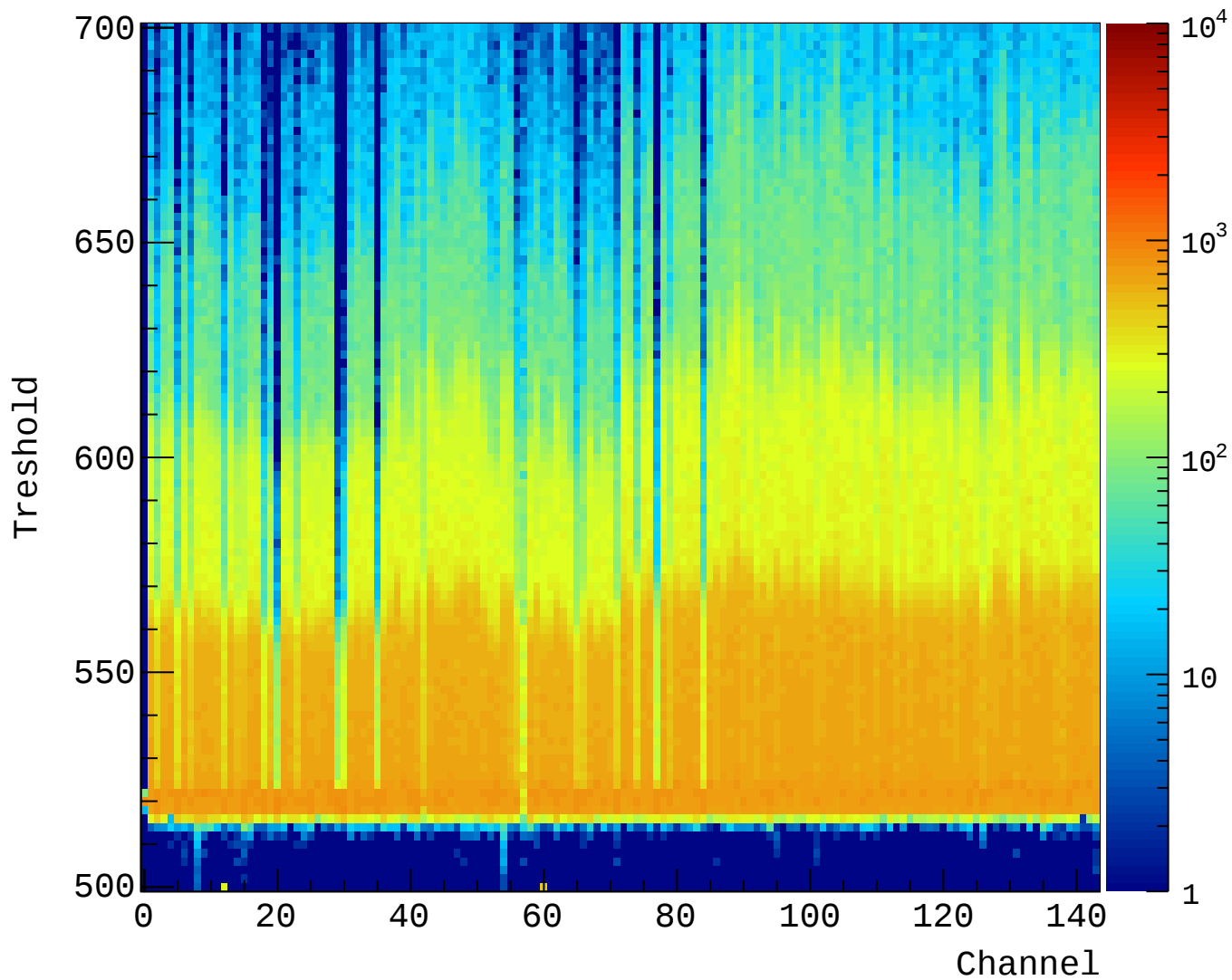
Threshold scan over center of channels: Chip C



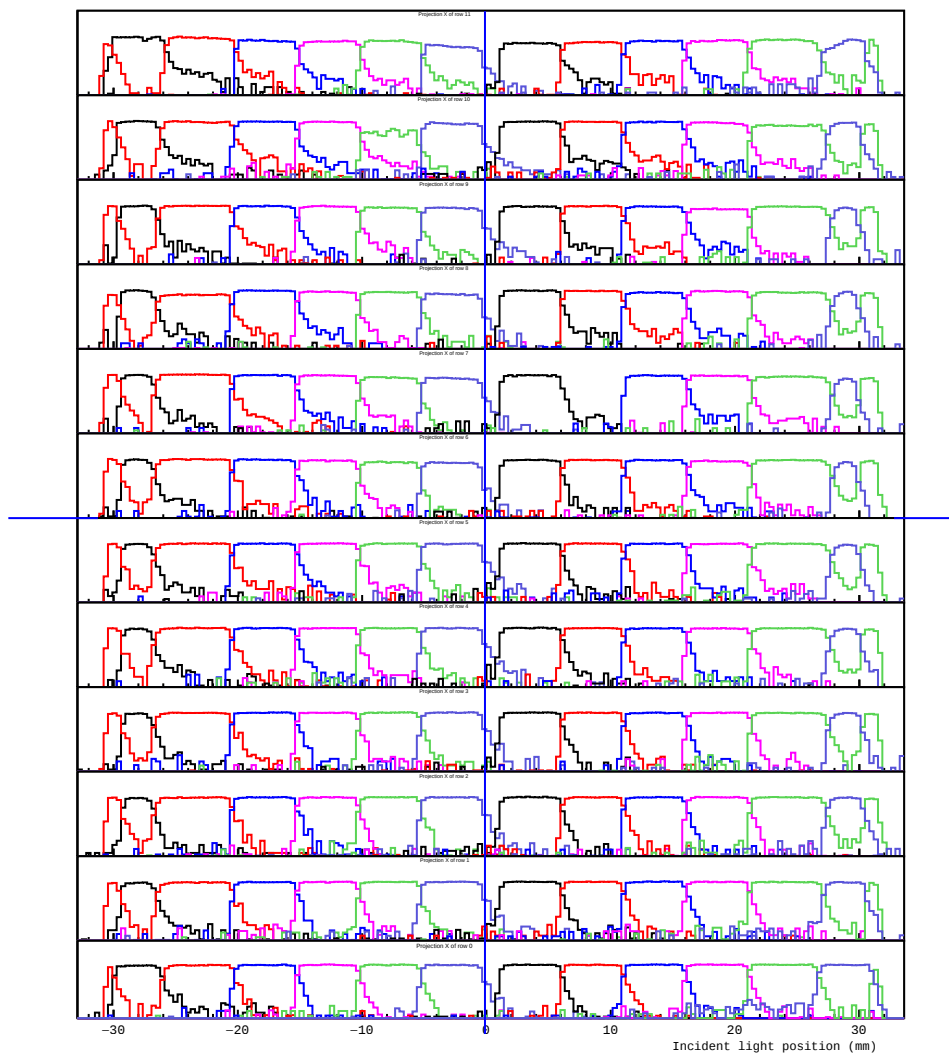
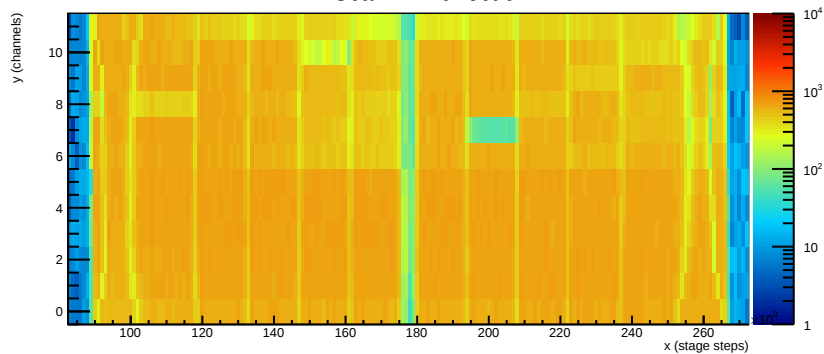
Threshold scan over center of channels: Chip D

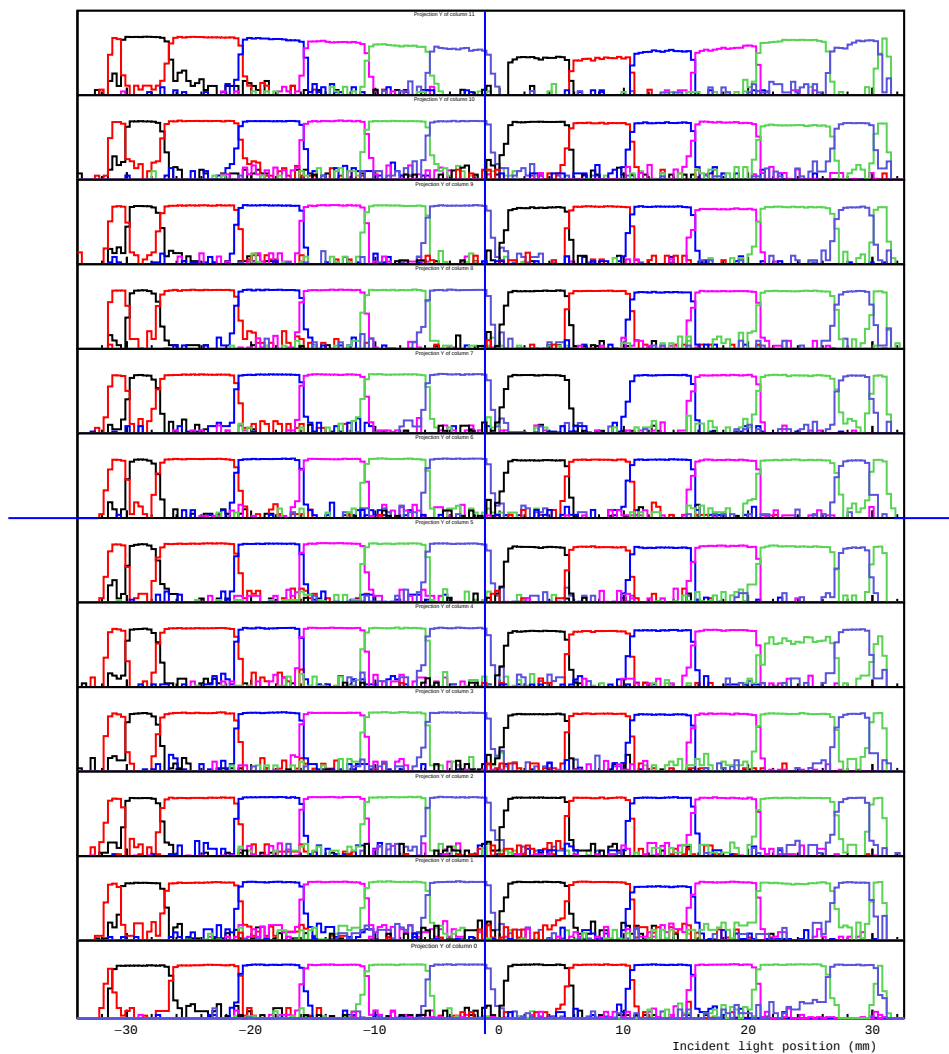
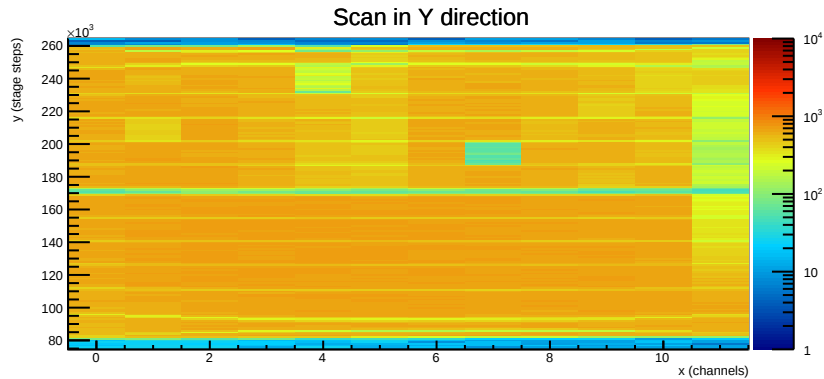


Threshold scan over the center of channels

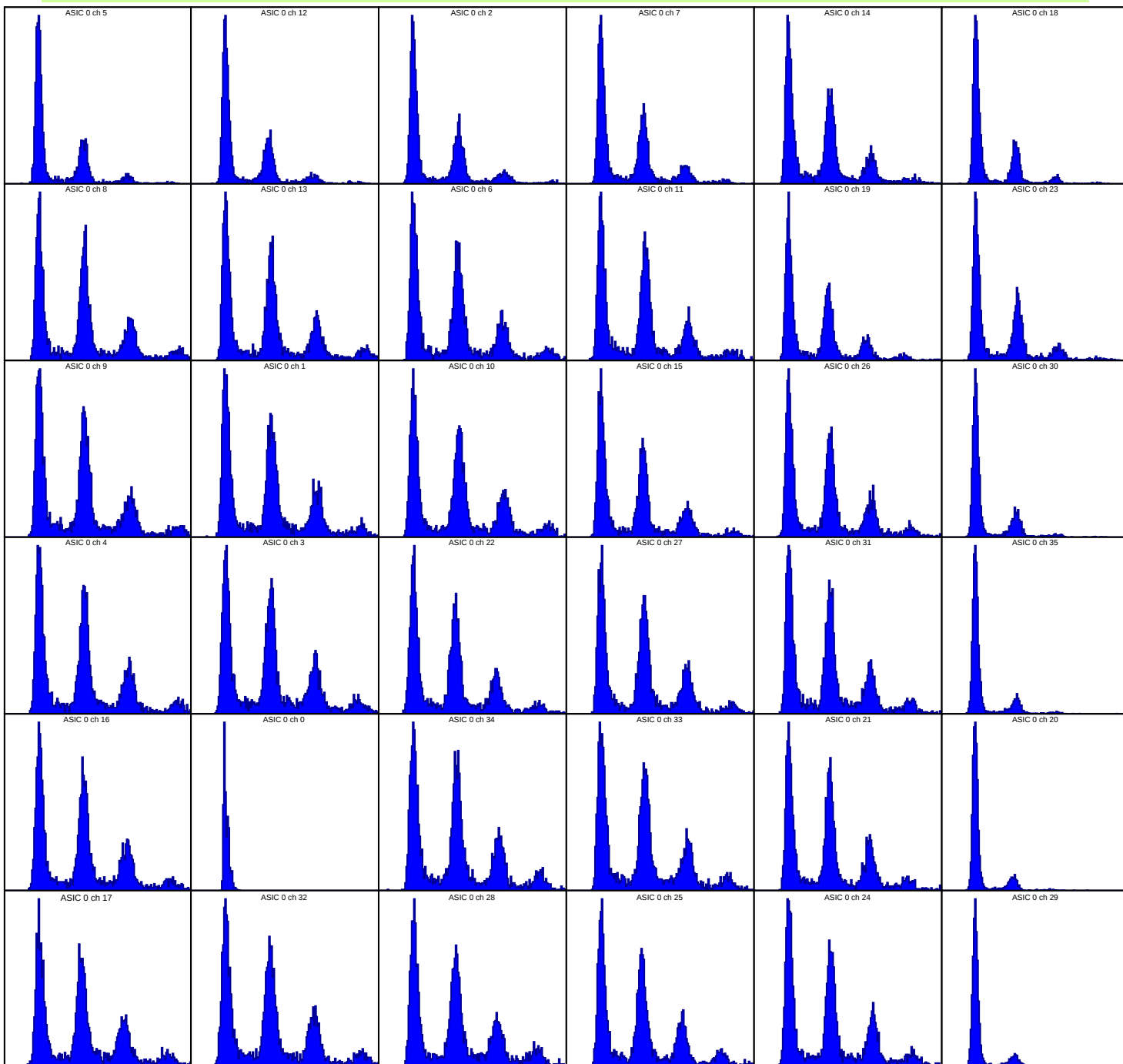


Scan in X direction

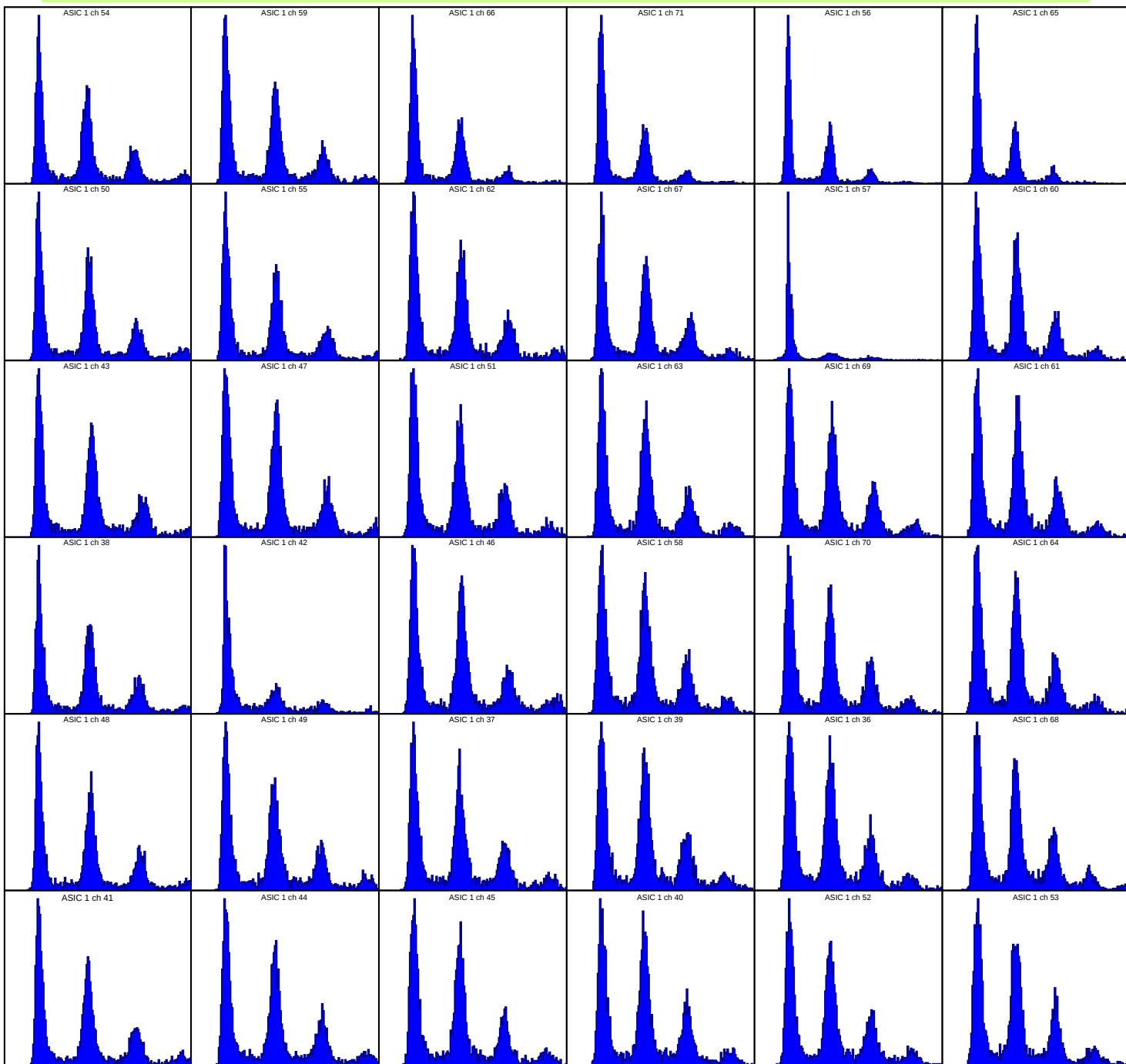




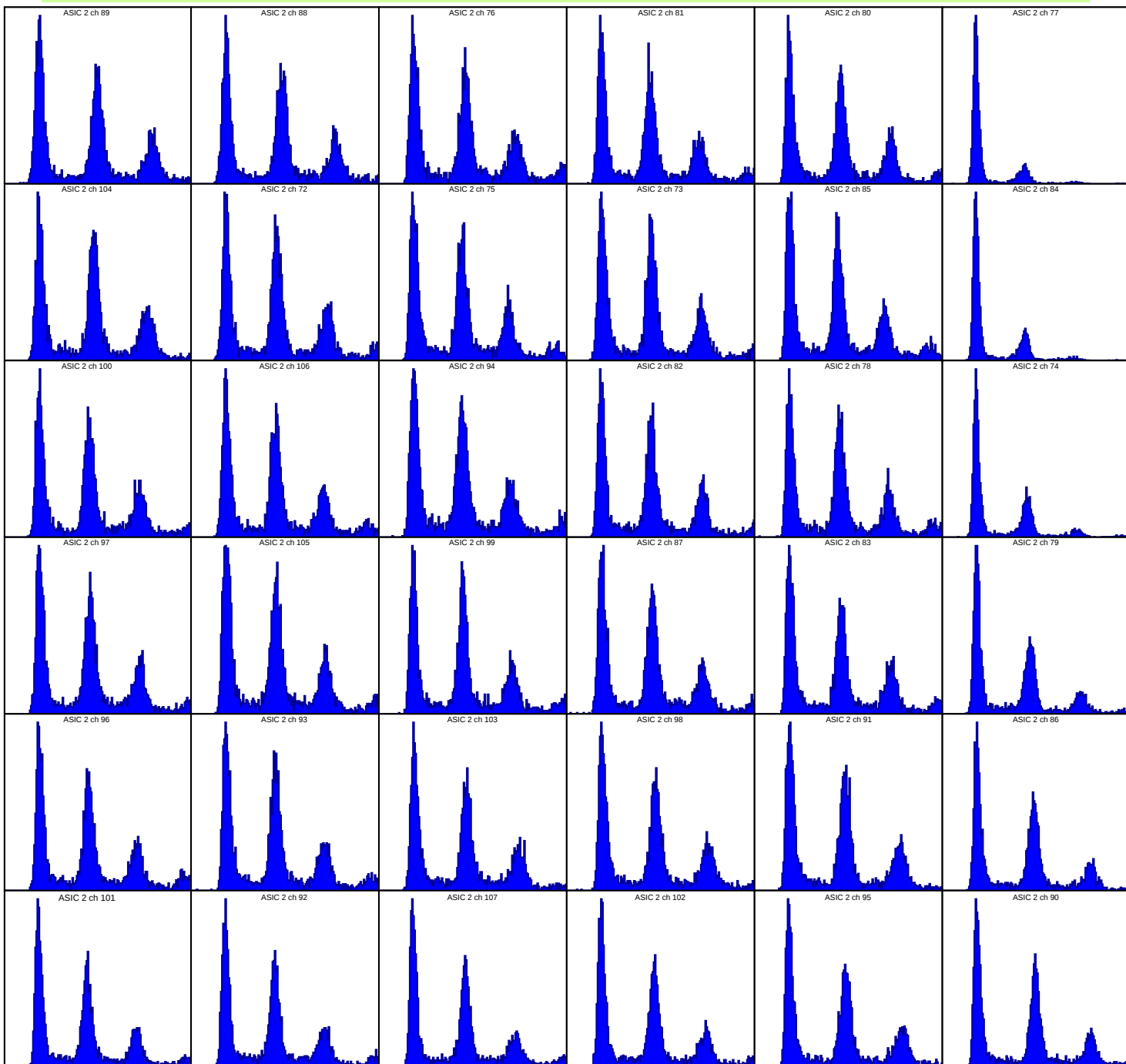
Charge scan over center of channels: Chip A



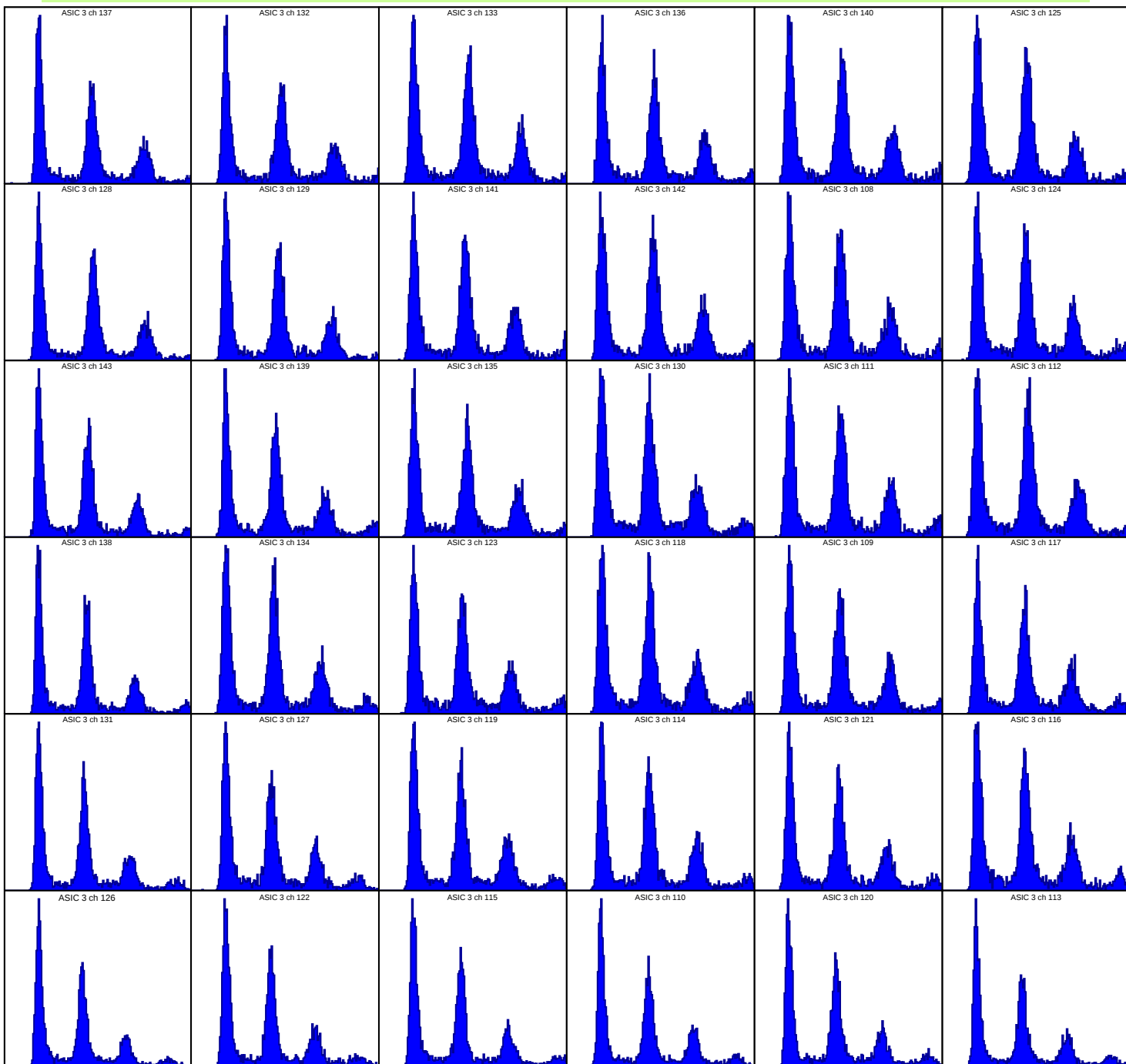
Charge scan over center of channels: Chip B



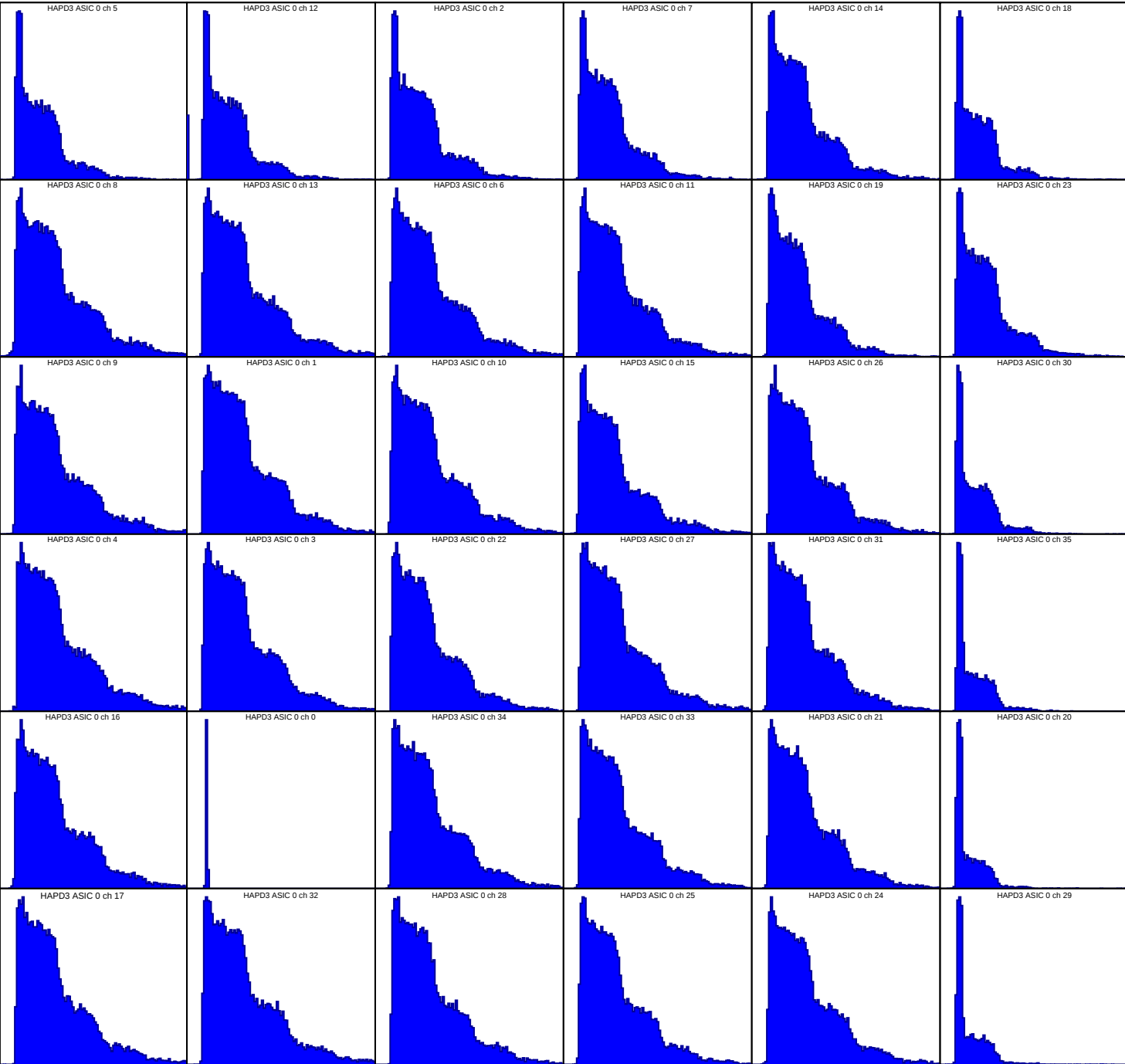
Charge scan over center of channels: Chip D



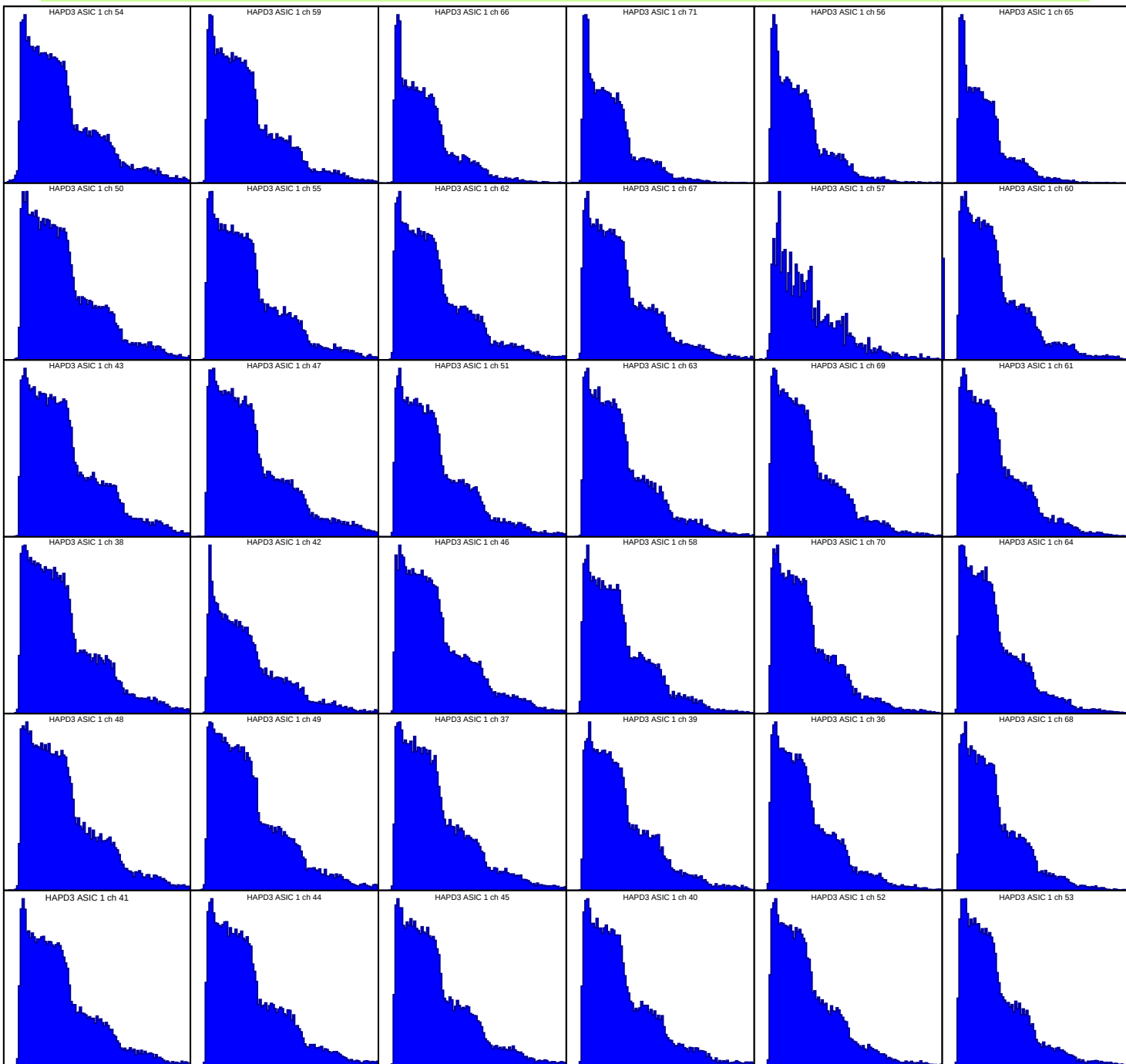
Charge scan over center of channels: Chip C



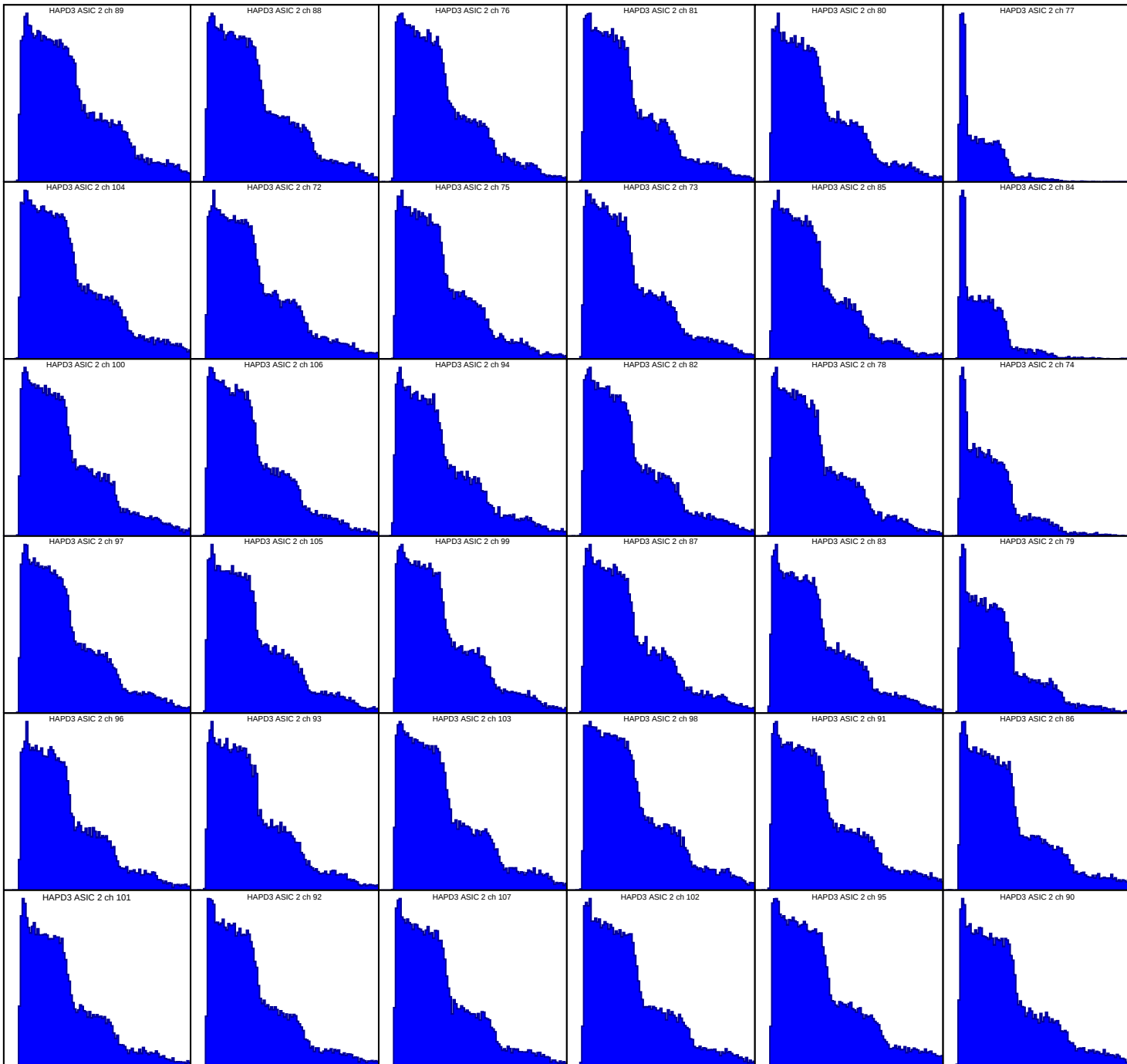
Treshhold scan over center of channels: Chip A



Treshold scan over center of channels: Chip B



Treshold scan over center of channels: Chip D



Treshhold scan over center of channels: Chip C

